TOSHIBA 2SK3176

TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL MOS TYPE (π -MOS V)

2 S K 3 1 7 6

HIGH SPEED, HIGH VOLTAGE SWITCHING APPLICATIONS SWITCHING REGULATOR, DC-DC CONVERTER AND MOTOR DRIVE **APPLICATIONS**

Low Drain-Source ON Resistance : $R_{DS(ON)} = 38 \,\mathrm{m}\Omega$ (Typ.)

High Forward Transfer Admittance : $|Y_{fs}| = 28 \,\mathrm{S}$ (Typ.)

Low Leakage Current : $I_{DSS} = 100 \,\mu\text{A}$ (Max.) ($V_{DS} = 200 \,\text{V}$)

Enhancement-Model : $V_{th} = 1.5 \sim 3.5 \text{ V } (V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA})$

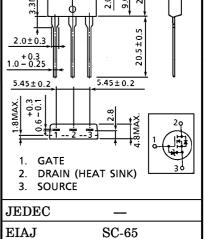
MAXIMUM RATINGS (Ta = 25°C)

CHARACTERIS	SYMBOL	RATING	UNIT	
Drain-Source Voltage	$v_{ m DSS}$	200	V	
Drain-Gate Voltage (R _{GS} = $20 \text{k}\Omega$)		$v_{ m DGR}$	200	V
Gate-Source Voltage	v_{GSS}	±20	V	
Drain Current	DC	$I_{\mathbf{D}}$	30	Α
	Pulse	I_{DP}	120	Α
Drain Power Dissipation	P_{D}	150	W	
Single Pulse Avalanche	EAS	925	mJ	
Avalanche Current	I_{AR}	30	Α	
Repetitive Avalanche En	E_{AR}	15	mJ	
Channel Temperature	$\mathrm{T_{ch}}$	150	°C	
Storage Temperature Range		$\mathrm{T_{stg}}$	-55~150	°C

$\emptyset 3.2 \pm 0.2$ 15.9 MAX.

INDUSTRIAL APPLICATIONS

Unit in mm



2-16C1B

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THERMAL CHARACTERISTICS

CHARACTERISTIC	SYMBOL	MAX.	UNIT
Thermal Resistance, Channel to Case	R _{th (ch-c)}	0.833	°C/W
Thermal Resistance, Channel to Ambient	R _{th (ch-a)}	50.0	°C/W

- $V_{DD} = 50 \text{ V}, T_{ch} = 25^{\circ}\text{C}, L = 1.66 \text{ mH}, I_{AR} = 30 \text{ A}, R_{G} = 25 \Omega$
- ** Repetitive rating; Pulse Width Limited by Max. junction temperature.

This transistor is an electrostatic sensitive device. Please handle with caution.

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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARA	CTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage	e Current	IGSS	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μ A
Drain Cut-off	Current	$I_{ m DSS}$	$V_{DS} = 200 \text{ V}, \ V_{GS} = 0 \text{ V}$	_	_	100	μ A
Drain-Source Voltage	Breakdown		$I_{ m D} = 10 \ { m mA}, \ { m V}_{ m GS} = 0 \ { m V}$	200	_	_	V
Gate Thresho	ld Voltage	$V_{ m th}$	$V_{DS} = 10 \text{ V}, I_{D} = 1 \text{ mA}$	1.5	_	3.5	V
Drain-Source	ON Resistance	RDS (ON)	$V_{GS} = 10 \text{ V}, I_{D} = 15 \text{ A}$	_	38	52	$\mathbf{m}\Omega$
Forward Tran Admittance	nsfer	Y _{fs}	$V_{DS} = 10 \text{ V}, I_{D} = 15 \text{ A}$	15	30	_	S
Input Capacitance Reverse Transfer Capacitance		$\mathrm{c}_{\mathrm{iss}}$	$V_{ m DS} = 10 m V, \ V_{ m GS} = 0 m V$ $ m f = 1 MHz$	_	5400	-	pF
		C _{rss}		_	580	_	
Output Capac	Output Capacitance			_	1900	_	
Switching Time	Rise Time	$t_{\mathbf{r}}$	$V_{GS} \stackrel{10 \text{ V}}{\circ} V_{OUT}$ $V_{GS} \stackrel{10 \text{ V}}{\circ} V_{OUT}$ $R_{L} = 6.7 \Omega$ $V_{DD} = 100 \text{ V}$ $V_{IN} : t_{r}, t_{f} < 5 \text{ ns,}$ $Duty \le 1\%, t_{W} = 10 \mu \text{s}$	_	15	_	
	Turn-on Time	t _{on}			55	_	ns
	Fall Time	t_f			25	_	115
	Turn-off Time	toff		_	190	_	
Total Gate Charge (Gate-Source Plus Gate-Drain)		$\mathbf{Q}_{\mathbf{g}}$	$V_{DD} = 160 \text{ V}, V_{GS} = 10 \text{ V}$	_	125	_	nC
Gate-Source Charge		$\mathbf{Q}_{\mathbf{g}\mathbf{s}}$	$I_{\mathrm{D}} = 30\mathrm{A}$	_	80	_	
Gate-Drain ("Miller") Charge		$\mathbf{Q}_{\mathbf{gd}}$			45	-	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Continuous Drain Reverse Current	$I_{ m DR}$	_	_	_	30	A
Pulse Drain Reverse Current	$I_{ m DRP}$	_	_	_	90	Α
Diode Forward Voltage	$V_{ m DSF}$	$I_{DR} = 30 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-2.0	V
Reverse Recovery Time	${ m t_{rr}}$	$I_{DR} = 30 \text{ A}, V_{GS} = 0 \text{ V}$	_	270	_	ns
Reverse Recovery Charge	$Q_{\mathbf{rr}}$	$dI_{DR}/dt = 100 A/\mu s$		3.0		μ C

MARKING

